

**Notice of References Cited**

Application/Control No.

09/687,794

Applicant(s)/Patent Under

Reexamination

PARRISH ET AL.

Examiner

Oanh L. Duong

Art Unit

2155

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0099812 A1	07-2002	DAVIS et al.	709/224
	B	US-6,026,440	02-2000	Shrader et al.	709/224
	C	US-6,438,716 B1	08-2002	Snover, Jeffrey Phillip	714/57
	D	US-6,397,244 B1	05-2002	Morimoto et al.	709/200
	E	US-6,513,031 B1	01-2003	Fries et al.	707/3
	F	US-6,433,795 B1	08-2002	MacNaughton et al.	345/738
	G	US-6,535,889 B1	03-2003	Headrick et al.	707/104.1
	H	US-6,370,571 B1	04-2002	Medin, Jr., Milo S.	709/218
	I	US-2002/0178232 A1	11-2002	FERGUSON, XAVIER	709/217
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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